

Application/Control No.	Applicant(s)/Pate Reexamination	ent under
10/584,447	TAKAKURA ET	AL.
Examiner	Art Unit	
lanet L. Enne-Smith	1633	

SEARCHED				
Class	Subclass	Date	Examiner	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
STIC Plus search	1-27-10	JLE		
EAST text search, see attached	1/28/2010	JLE		
Palm inventor name search	1/27/2010	JLE		
East search updated	8/15/2010	JLE		